Notice of References Cited

Application/Control No. 10/766,485	Reexamination	Applicant(s)/Patent Under Reexamination LEE, JONG-WON		
Examiner	Art Unit			
George Nauven	3723	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,322,434 B1	11-2001	Satoh et al.	451/443
	В	US-6,234,868 B1	05-2001	Easter et al.	451/5
	С	US-6,036,583 A	03-2000	Perlov et al.	451/56
	D	US-5,809,157 A	09-1998	Grumazescu, Mihai	381/412
	E	US-5,904,615 A	05-1999	Jeong et al.	451/443
	F	US-5,607,341 A	03-1997	Leach, Michael A.	451/41
	G	US-4,228,373	10-1980	Funderburg, William S.	310/20
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0	•				
	Р					
	Q					
	R					
	S					
	Т			·		

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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	x				

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